

Notice of References Cited	Application/Control No. 10/542,323	Applicant(s)/Patent Under Reexamination DEMARNE ET AL.	
	Examiner Melenie McCormick	Art Unit 1655	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,458,407	10-2002	Miki et al.	426/651
*	C	US-6,331,320	12-2001	Nakahara et al.	424/725
*	D	US-5,073,628	12-1991	Matsuhashi et al.	530/379
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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